

**Search Notes**

Application/Control No.

10/809,545

Examiner

Yonel Beaulieu

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

3661

**SEARCHED**

| Class | Subclass | Date     | Examiner |
|-------|----------|----------|----------|
| 701   | 36       | 5/8/2006 | YB       |
|       | 41       |          |          |
|       | 42       |          |          |
| 307   | 9.1      | 5/8/2006 | YB       |
|       | 10.1     |          |          |
| 180   | 199      | 5/8/2006 | YB       |
| 340   | 932.2    | 5/8/2006 | YB       |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date     | Examiner |
|-------|----------|----------|----------|
| 701   | 36       | 5/8/2006 | YB       |
|       | 41       |          |          |
| 180   | 199      | 5/8/2006 | YB       |
|       |          |          |          |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                | DATE     | EXMR |
|----------------|----------|------|
| WEST (Bwd/Fwd) | 5/8/2006 | YB   |
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